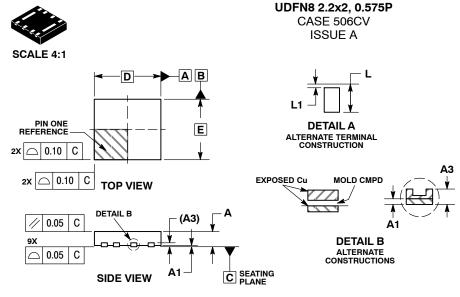
MECHANICAL CASE OUTLINE



DATE 21 JUL 2015

- NOTES:
 1. DIMENSIONING AND TOLERANCING PER
- DIMENSIONING AND TOLEHANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSIONS IS APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.25 MM FROM TERMINAL TIP.

	MILLIMETERS			
DIM	MIN	MAX		
Α	0.45	0.55		
A1	0.00	0.05		
A3	0.127 REF			
b	0.15	0.25		
D	2.20 BSC			
E	2.00 BSC			
E3	0.20 BSC 0.575 BSC 0.40 BSC			
е				
e2				
L	0.25	0.35		
L1	0.05	0.15		
L2	0.95	1.05		

GENERIC MARKING DIAGRAM*



XX = Specific Device Code

= Date Code

*This information is generic. Please refer to device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot " ■", may or may not be present.

DETAIL A 1	10X b
2X L2 8 5 5 62 E3 > 4	0.20
BOTTOM VIEW	PACKAGE 2.30 4X 0.50 1 2.30 4X 0.50 - 0.22 - 0.575 - 0.20 DIMENSIONS: MILLIMETERS

DOCUMENT NUMBER:	98AON79913F	Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLED"	' '
DESCRIPTION:	UDFN8 2.2X2, 0.575P		PAGE 1 OF 1

ON Semiconductor and (III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.